

SEMiX® 33c

## Trench IGBT Modules

### SEMiX 453GD176HDc

Preliminary Data

#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability

#### Typical Applications

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

#### Remarks

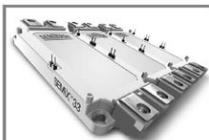
- short circuit capability is tested @  $V_{CC}=1000V$  (all other static parameters are tested @  $V_{CC}=1200V$ )

Absolute Maximum Ratings		$T_{case} = 25^{\circ}C$ , unless otherwise specified		
Symbol	Conditions	Values	Units	
<b>IGBT</b>				
$V_{CES}$	$T_J = 25^{\circ}C$	1700	V	
$I_C$	$T_J = 150^{\circ}C$	$T_C = 25^{\circ}C$	445	A
		$T_C = 80^{\circ}C$	315	A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Crom}$	600	A	
$V_{GES}$		$\pm 20$	V	
$t_{psc}$	$V_{CC} = 1200V$ ; $V_{GE} \leq 20V$ ; $T_J = 125^{\circ}C$ $V_{CES} < 1700V$	10	$\mu s$	
<b>Inverse Diode</b>				
$I_F$	$T_J = 150^{\circ}C$	$T_C = 25^{\circ}C$	545	A
		$T_C = 80^{\circ}C$	365	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{FRom}$	600	A	
$I_{FSM}$	$t_p = 10\text{ ms}$ ; sin. $T_J = 25^{\circ}C$	2900	A	
<b>Module</b>				
$I_{T(RMS)}$		600	A	
$T_{vj}$		- 40 ... + 150	$^{\circ}C$	
$T_{stg}$		- 40 ... + 125	$^{\circ}C$	
$t_{tot}$	AC, 1 min.	4000	V	

Characteristics		$T_{case} = 25^{\circ}C$ , unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
<b>IGBT</b>						
$V_{GE(th)}$	$V_{GE} = V_{CE}$ ; $I_C = 12\text{ mA}$	5,2	5,8	6,4	V	
$I_{CES}$	$V_{GE} = 0V$ ; $V_{CE} = V_{CES}$		$T_J = 25^{\circ}C$	0,45	mA	
			$T_J = 125^{\circ}C$	1	1,2	V
$V_{CE0}$			$T_J = 25^{\circ}C$	0,9	1,1	V
			$T_J = 125^{\circ}C$	3,3	4,2	m $\Omega$
$r_{CE}$	$V_{GE} = 0V$		$T_J = 25^{\circ}C$	5,2	6	m $\Omega$
			$T_J = 125^{\circ}C$	2	2,45	V
$V_{CE(sat)}$	$I_{Crom} = 300A$ ; $V_{GE} = 15V$		$T_J = 25^{\circ}C_{chiplev.}$	2,45	2,9	V
			$T_J = 125^{\circ}C_{chiplev.}$	28,4	1,1	nF
$C_{ios}$	$V_{CE} = 25V$ ; $V_{GE} = 0V$	$f = 1\text{ MHz}$		0,88	nF	
$C_{oss}$				2800	nC	
$C_{res}$				335	70	ns
$Q_G$	$V_{GE} = -8V \dots +15V$		215	990	mJ	
$t_{s(off)}$	$R_{Con} = 4,3\ \Omega$	$V_{CC} = 1200V$ $I_{Crom} = 300A$ $T_J = 125^{\circ}C$		150	ns	
				125	mJ	
$R_{th(j-c)}$	per IGBT			0,071	K/W	



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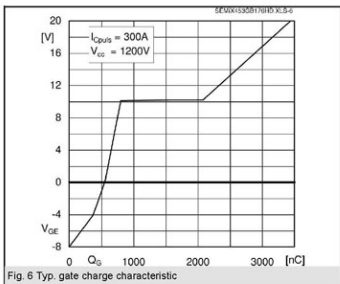
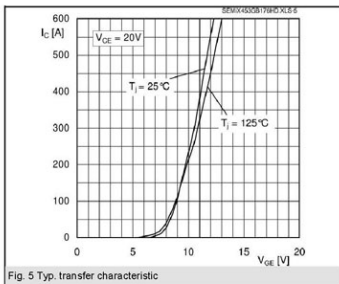
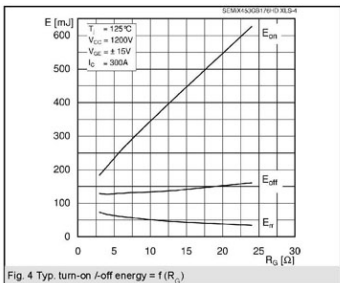
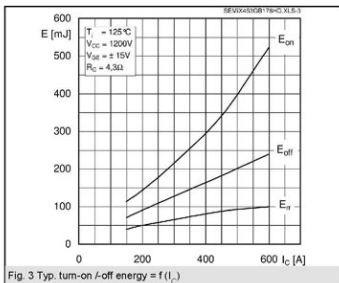
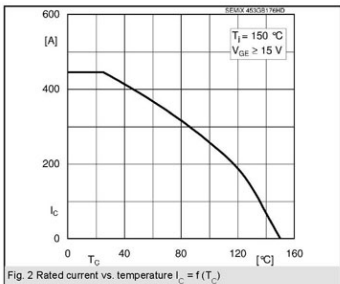
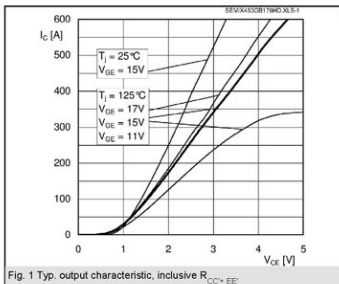
Characteristics		min.	typ.	max.	Units
<b>Inverse Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 300 A; V_{GE} = 0 V$	$T_J = 25 ^\circ C_{chiplev.}$	1,5	1,7	V
		$T_J = 125 ^\circ C_{chiplev.}$	1,45	1,65	V
$V_{FO}$		$T_J = 25 ^\circ C$	1,1	1,3	V
		$T_J = 125 ^\circ C$	0,9	1,1	V
$r_F$		$T_J = 25 ^\circ C$	1,3		mΩ
		$T_J = 125 ^\circ C$	1,8		mΩ
$I_{RRM}$	$I_{Fnom} = 300 A$	$T_J = 125 ^\circ C$	350		A
$O_{rr}$	$di/dt = 4700 A/\mu s$		115		μC
$E_{rr}$	$V_{GE} = -15 V; V_{CC} = 1200 V$		65		mJ
$R_{\theta(j-c)}$	per diode			0,11	K/W
<b>Module</b>					
$L_{DE}$			20		nH
$R_{CC+EE}$	res., terminal-chip	$T_{c380} = 25 ^\circ C$	0,7		mΩ
		$T_{c380} = 125 ^\circ C$	1		mΩ
$R_{\theta(c-s)}$	per module		0,014		K/W
$M_9$	to heat sink M5		3	5	Nm
$M_1$	to terminals M6		2,5	5	Nm
w				900	g
<b>Temperature sensor</b>					
$R_{100}$	$T_c = 100^\circ C (R_{25} = 5 k\Omega)$		0,493±5%		kΩ
$B_{100/125}$	$R(T) = R_{100} \exp[B_{100/125} (1/T - 1/T_{100})]$ $T[K]; B$		3550±2%		K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.



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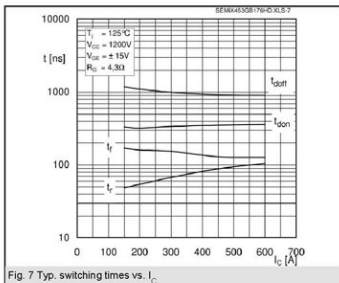


Fig. 7 Typ. switching times vs.  $I_c$

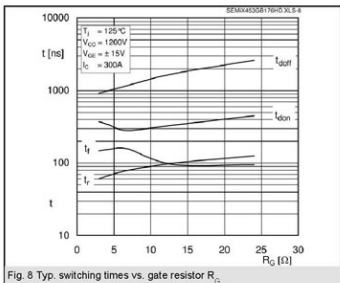


Fig. 8 Typ. switching times vs. gate resistor  $R_G$

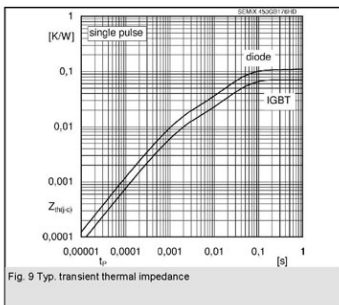


Fig. 9 Typ. transient thermal impedance

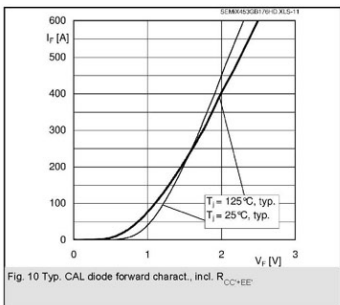


Fig. 10 Typ. CAL diode forward char., incl.  $R_{CC+EE}$

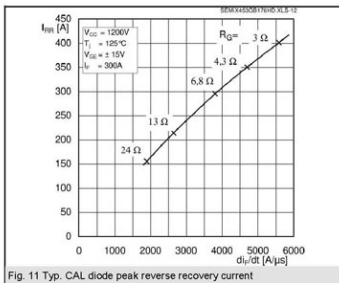


Fig. 11 Typ. CAL diode peak reverse recovery current

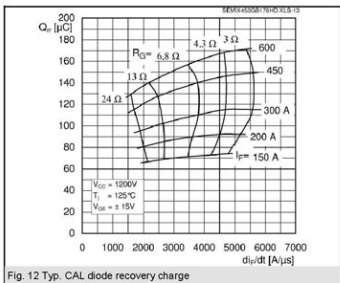
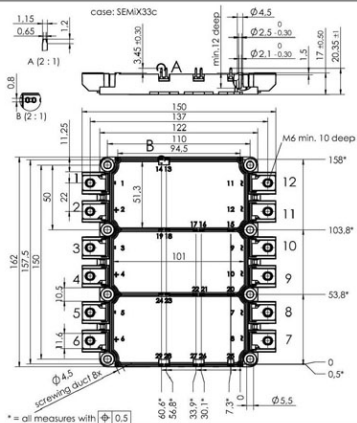


Fig. 12 Typ. CAL diode recovery charge

# SEMIX 453GD176HDc



Case SEMIX 33c

